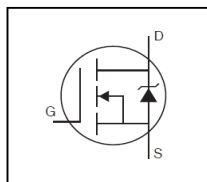


特性

- 先进工艺技术
- 超低导通电阻
- 动态 dv/dt 额定值
- 工作温度 175°C
- 快速开关
- 允许达到 T_{jmax} 的重复雪崩
- 无铅，符合RoHS要求
- 汽车认证 *

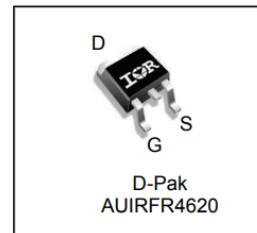
描述

这款 HEXFET® 功率MOSFET专为汽车应用而设计，采用最新的工艺技术实现单位硅面积极低的导通电阻。该设计的其他特点包括 175°C 工作结温、开关速度快和提高重复雪崩额定值。通过结合以上特点，使该设计成为一种极其高效和可靠的器件，可用于汽车应用和各种其他应用。



HEXFET®功率MOSFET

V_{DS}		200V
$R_{DS(on)}$	typ. max.	64mΩ 78mΩ
I_D		24A



G	D	S
Gate	Drain	Source

Base part number	Package Type	Standard Pack		Orderable Part Number
		Form	Quantity	
AUIRFR4620	D-Pak	Tube	75	AUIRFR4620
		Tape and Reel Left	3000	AUIRFR4620TRL

绝对最大额定值

超过“绝对最大额定值”所列值的应力可能会对器件造成永久性损坏。这些仅仅是应力额定值，并不意味着器件在这些或任何其他超过该规范所示的条件下能够正常运行。延长暴露在绝对最大额定值条件的时间可能会影响器件的可靠性。热阻抗和功率耗散额定值是在装板和静止空气条件下测得的。环境温度（TA）为 25°C，除非另有规定。

Symbol	Parameter	Max.	Units
$I_D @ T_c = 25^\circ\text{C}$	Continuous Drain Current, $V_{GS} @ 10\text{V}$	24	A
$I_D @ T_c = 100^\circ\text{C}$	Continuous Drain Current, $V_{GS} @ 10\text{V}$	17	
I_{DM}	Pulsed Drain Current ①	100	
$P_D @ T_c = 25^\circ\text{C}$	Maximum Power Dissipation	144	W
	Linear Derating Factor	0.96	W/°C
V_{GS}	Gate-to-Source Voltage	± 20	V
E_{AS}	Single Pulse Avalanche Energy (Thermally Limited) ②	113	mJ
I_{AR}	Avalanche Current ①	See Fig. 14, 15, 22a, 22b	A
E_{AR}	Repetitive Avalanche Energy ①		mJ
dv/dt	Peak Diode Recovery dv/dt ③	54	V/ns
T_J	Operating Junction and	-55 to + 175	°C
T_{STG}	Storage Temperature Range		
	Soldering Temperature, for 10 seconds (1.6mm from case)	300	

热阻抗

Symbol	Parameter	Typ.	Max.	Units
$R_{\theta JC}$	Junction-to-Case ⑧	---	1.045	°C/W
$R_{\theta JA}$	Junction-to-Ambient (PCB Mount) ⑦	---	50	
$R_{\theta JA}$	Junction-to-Ambient ⑦	---	110	

HEXFET® 是英飞凌的注册商标。

*认证标准可在 www.infineon.com 上找到

本数据手册的原文使用英文撰写。为方便起见，英飞凌提供了译文；由于翻译过程中可能使用了自动化工具，英飞凌不保证译文的准确性。为确认准确性，请务必访问 infineon.com 参考最新的英文版本（控制文档）。

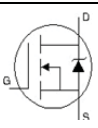
静态参数特性在 $T_J = 25^\circ\text{C}$ 时测得（除非另有规定）

	Parameter	Min.	Typ.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	200	---	---	V	$V_{GS} = 0V, I_D = 250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_J$	Breakdown Voltage Temp. Coefficient	---	0.23	---	V/ $^\circ\text{C}$	Reference to 25°C , $I_D = 5mA$ ①
$R_{DS(on)}$	Static Drain-to-Source On-Resistance	---	64	78	m Ω	$V_{GS} = 10V, I_D = 15A$ ④
$V_{GS(th)}$	Gate Threshold Voltage	3.0	---	5.0	V	$V_{DS} = V_{GS}, I_D = 100\mu A$
g_{fs}	Forward Trans conductance	37	---	---	S	$V_{DS} = 50V, I_D = 15A$
$R_{G(int)}$	Internal Gate Resistance	---	2.6	---	Ω	
I_{DSS}	Drain-to-Source Leakage Current	---	---	20	μA	$V_{DS} = 200V, V_{GS} = 0V$
		---	---	250		$V_{DS} = 200V, V_{GS} = 0V, T_J = 125^\circ\text{C}$
I_{GSS}	Gate-to-Source Forward Leakage	---	---	100	nA	$V_{GS} = 20V$
	Gate-to-Source Reverse Leakage	---	---	-100		$V_{GS} = -20V$

动态电气特性在 $T_J = 25^\circ\text{C}$ 时测得（除非另有规定）

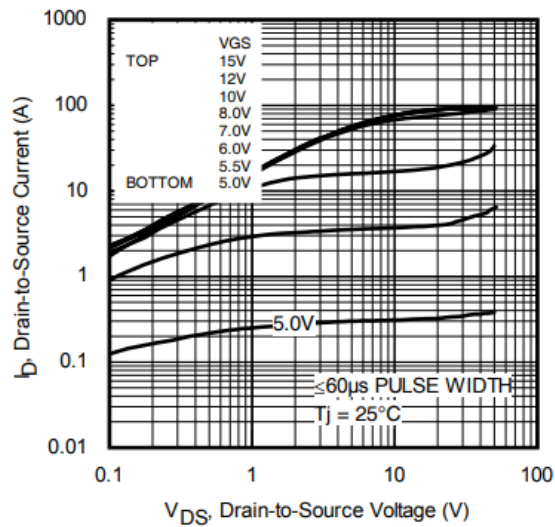
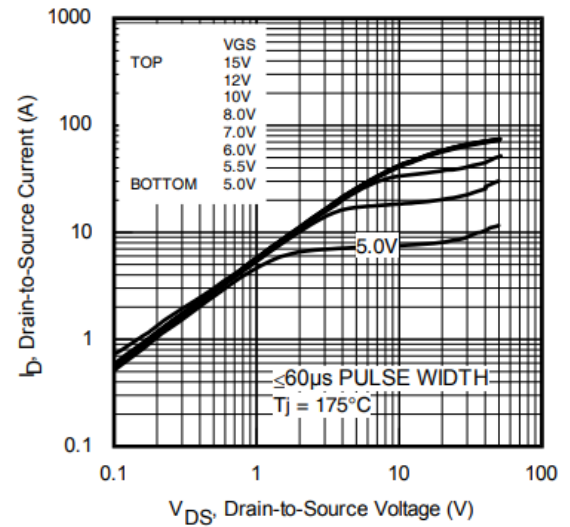
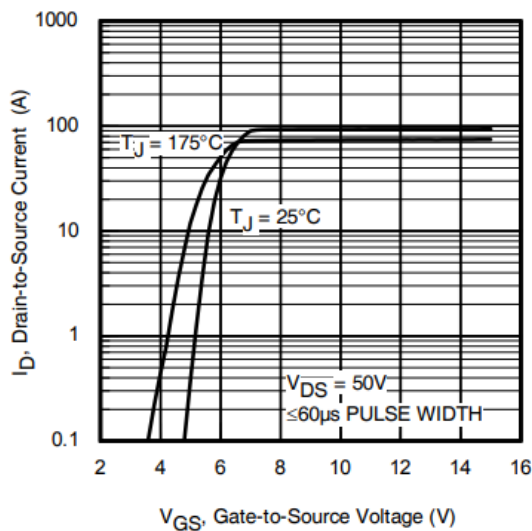
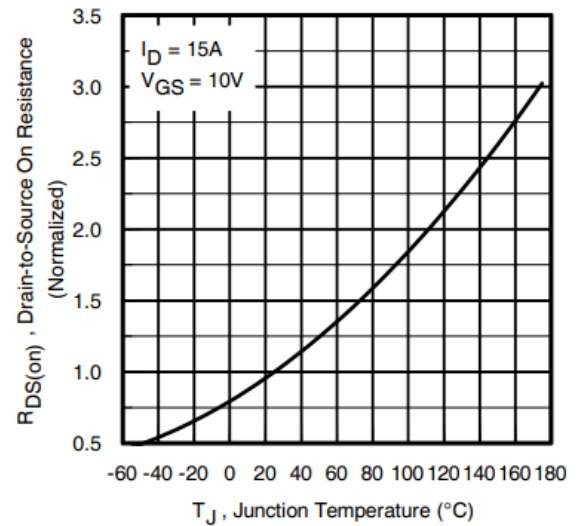
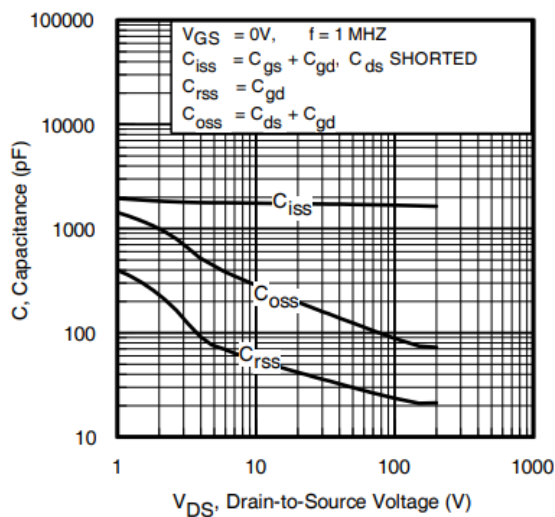
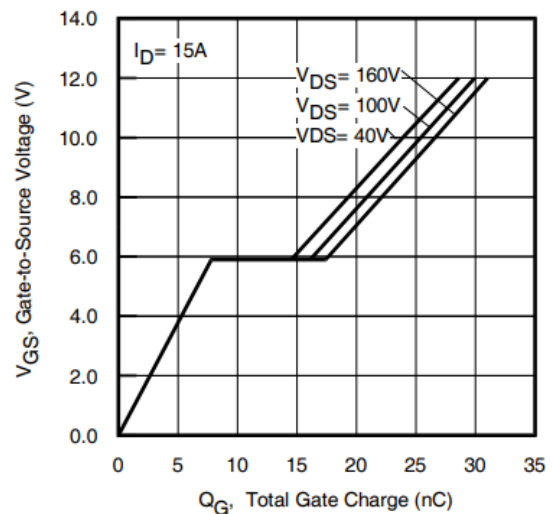
Q_g	Total Gate Charge	---	25	38	nC	$I_D = 15A, V_{DS} = 100V, V_{GS} = 10V$ ④
Q_{gs}	Gate-to-Source Charge	---	8.2	---		
Q_{gd}	Gate-to-Drain Charge	---	7.9	---		
Q_{sync}	Total Gate Charge Sync. ($Q_g - Q_{gd}$)	---	17	---		
$t_{d(on)}$	Turn-On Delay Time	---	13.4	---	ns	$V_{DD} = 130V, I_D = 15A, R_G = 7.3\Omega, V_{GS} = 10V$ ④
t_r	Rise Time	---	22.4	---		
$t_{d(off)}$	Turn-Off Delay Time	---	25.4	---		
t_f	Fall Time	---	14.8	---		
C_{iss}	Input Capacitance	---	1710	---	pF	$V_{GS} = 0V, V_{DS} = 50V, f = 1.0MHz, V_{GS} = 0V, V_{DS} = 0V$ to 160V ⑥
C_{oss}	Output Capacitance	---	125	---		
C_{rss}	Reverse Transfer Capacitance	---	30	---		
$C_{oss\ eff. (ER)}$	Effective Output Capacitance (Energy Related)	---	113	---		
$C_{oss\ eff. (TR)}$	Effective Output Capacitance (Time Related)	---	317	---		$V_{GS} = 0V, V_{DS} = 0V$ to 160V ⑤

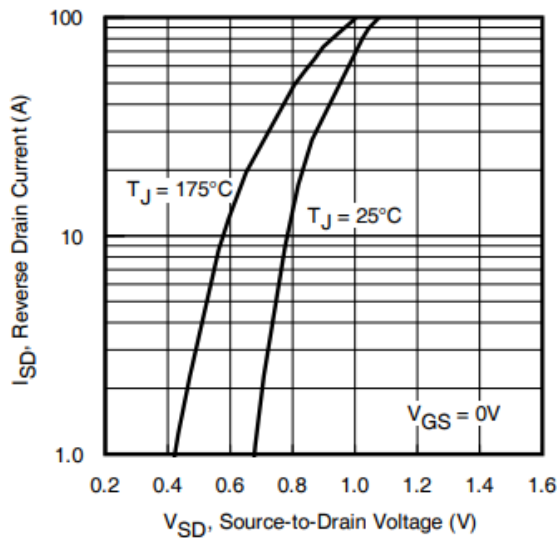
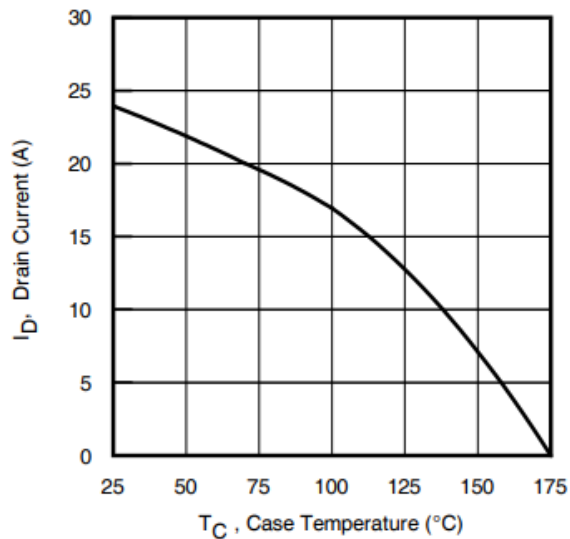
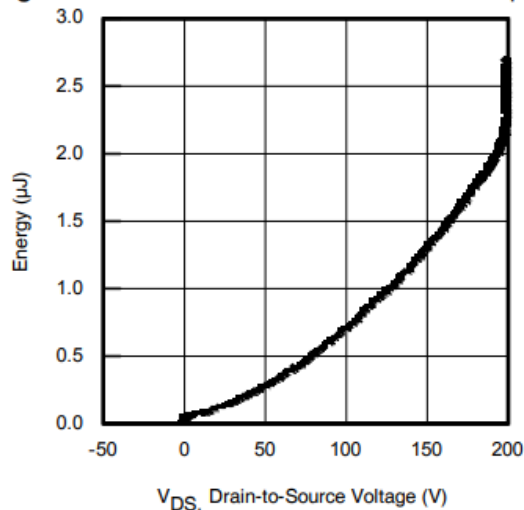
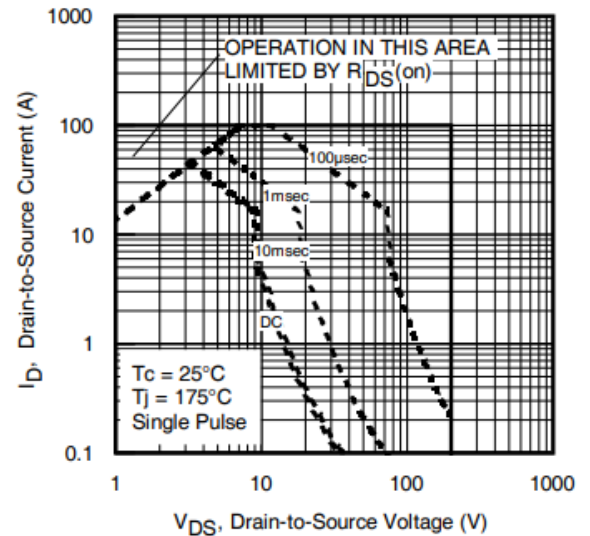
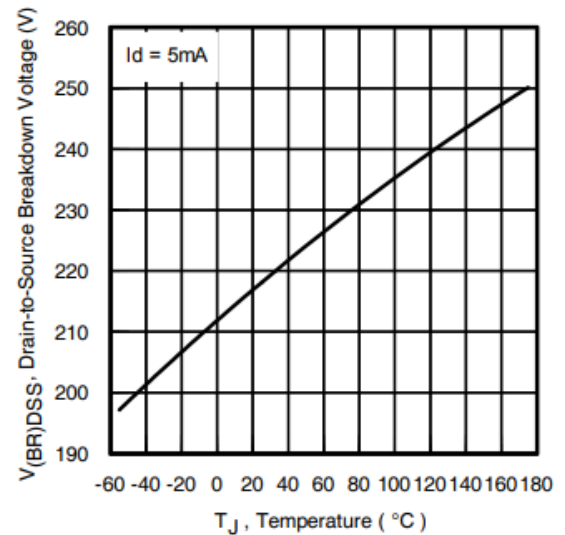
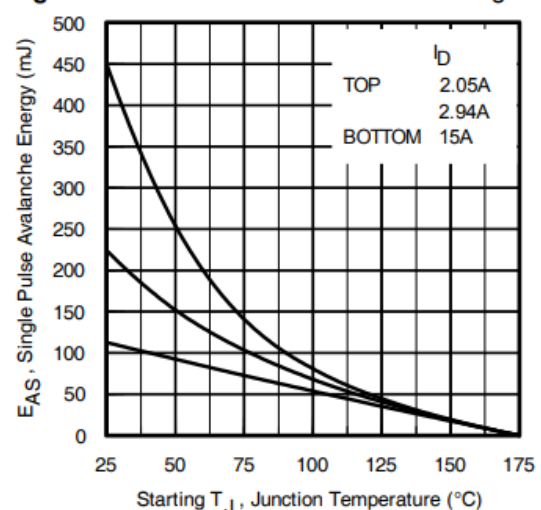
二极管特性

	Parameter	Min.	Typ.	Max.	Units	Conditions
I_S	Continuous Source Current (Body Diode)	---	---	24	A	MOSFET symbol showing the integral reverse p-n junction diode. 
I_{SM}	Pulsed Source Current (Body Diode) ①	---	---	100		
V_{SD}	Diode Forward Voltage	---	---	1.3	V	$T_J = 25^\circ\text{C}, I_S = 15A, V_{GS} = 0V$ ④
t_{rr}	Reverse Recovery Time	---	78	---	ns	$T_J = 25^\circ\text{C}$ $T_J = 125^\circ\text{C}$ $V_R = 100V,$
		---	99	---		
Q_{rr}	Reverse Recovery Charge	---	294	---	nC	$T_J = 25^\circ\text{C}$ $T_J = 125^\circ\text{C}$ $I_F = 15A$ $di/dt = 100A/\mu s$ ④
		---	432	---		
		---	7.6	---	A	$T_J = 25^\circ\text{C}$
t_{on}	Forward Turn-On Time	Intrinsic turn-on time is negligible (turn-on is dominated by $L_S + L_D$)				

注:

- ① 重复额定值；脉冲宽度受最高结温限制。
- ② 受 T_{Jmax} 限制，初始 $T_J = 25^\circ\text{C}$ 、 $L = 1.0mH$ 、 $R_G = 25\Omega$ 、 $I_{AS} = 15A$ 、 $V_{GS} = 10V$ 。不建议在高于此值的情况运行器件。
- ③ $I_{SD} \leq 15A$ ， $di/dt \leq 634A/\mu s$ ， $V_{DD} \leq V_{(BR)DSS}$ ， $T_J \leq 175^\circ\text{C}$ 。
- ④ 脉冲宽度 $\leq 400\mu s$ ；占空比 $\leq 2\%$ 。
- ⑤ $C_{oss\ eff. (TR)}$ 是一个固定电容值，当 V_{DS} 从 0 上升至 $80\% V_{DSS}$ 时，其充电时间与 C_{oss} 相同。
- ⑥ $C_{oss\ eff. (ER)}$ 是一个固定电容值，当 V_{DS} 从 0 上升至 $80\% V_{DSS}$ 时，其产生与 C_{oss} 相同的热量。
- ⑦ 安装在 1 英寸方形 PCB（FR-4 或 G-10 材料）上时。有关推荐的封装和焊接技术，请参阅应用注释 #AN-994
- ⑧ R_θ 在 T_J 约 90°C 时测得。


Fig. 1 Typical Output Characteristics

Fig. 2 Typical Output Characteristics

Fig. 3 Typical Transfer Characteristics

Fig. 4 Normalized On-Resistance vs. Temperature

Fig 5. Typical Capacitance vs. Drain-to-Source Voltage

Fig 6. Typical Gate Charge vs. Gate-to-Source Voltage


Fig. 7 Typical Source-to-Drain Diode Forward Voltage

Fig. 9 Maximum Drain Current vs. Case Temperature

Fig. 11 Typical C_{oss} Stored Energy

Fig 8. Maximum Safe Operating Area

Fig 10. Drain-to-Source Breakdown Voltage

Fig 12. Maximum Avalanche Energy vs. Drain Current

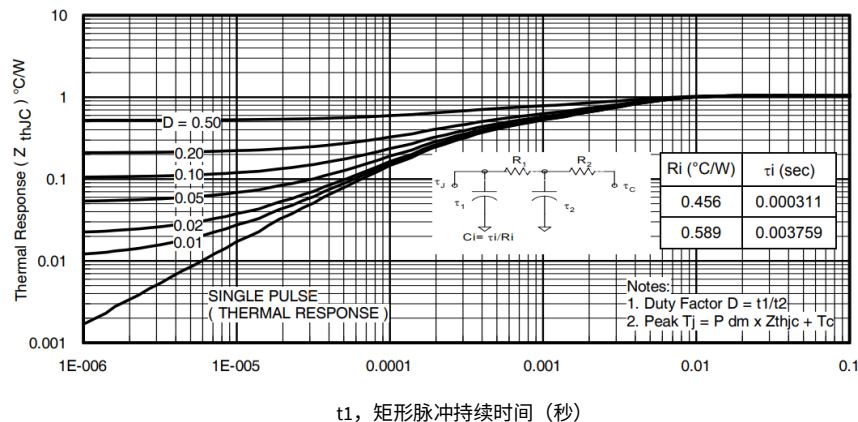


图 13.最大有效瞬态热阻，结到壳

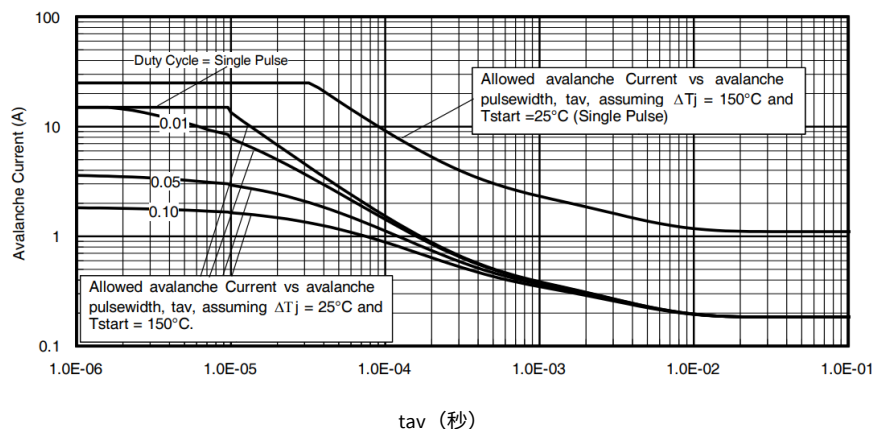


图 14.典型雪崩电流与脉冲宽度

关于重复的雪崩曲线的注释，图 14、15：（有关更多信息，请参阅www.infineon.com 上的 AN-1005）

1. 雪崩失效假设：

纯粹的热现象和失效发生在结温远超 T_{jmax} 的情况下。这对每种零件类型都是有效的。

2. 只要不超过 T_{jmax} ，就可以在雪崩中安全运行。

3. 如下公式基于图 22a、22b 所示的电路和波形。

4. $P_D(ave)$ = 每个雪崩脉冲的平均功率耗散。

5. BV = 额定击穿电压（1.3 系数，考虑雪崩期间的电压增加）。

6. I_{av} = 可允许的雪崩电流。

7. ΔT = 可允许的结温上升，不得超过 T_{jmax} （图 13、14 中假设为 $25^{\circ}C$ ）。

t_{av} = 雪崩的平均时间。

D = 雪崩占空比 = $t_{av} \cdot f$

$Z_{thJC}(D, t_{av})$ = 瞬态热阻抗，见图 13)

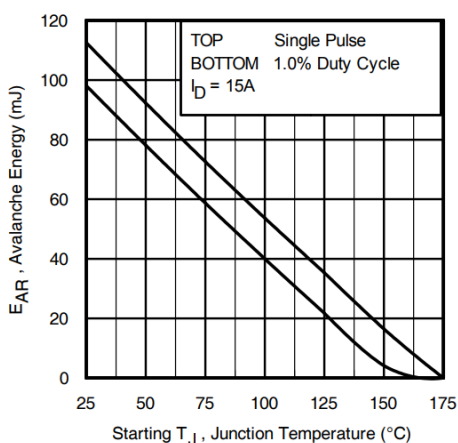
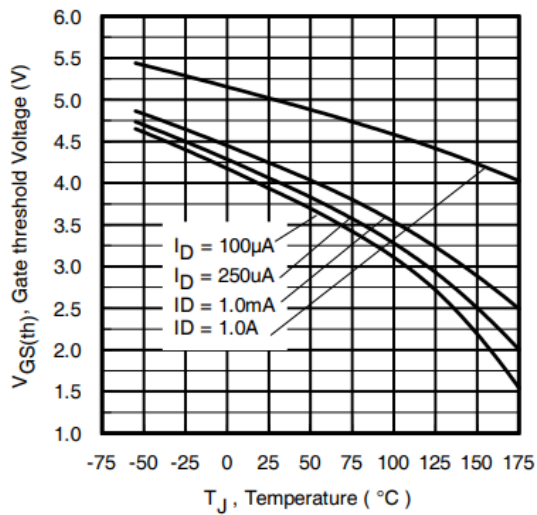
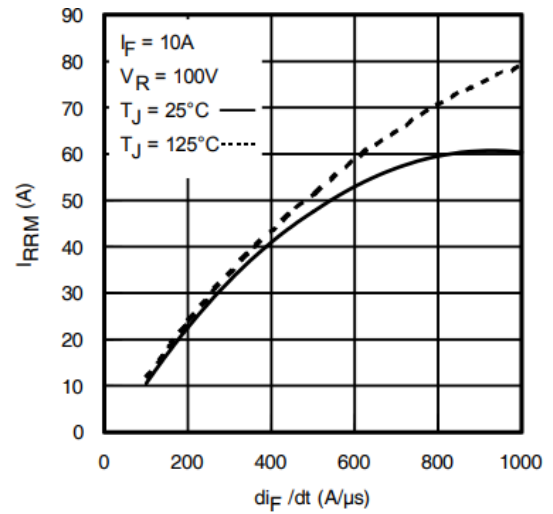
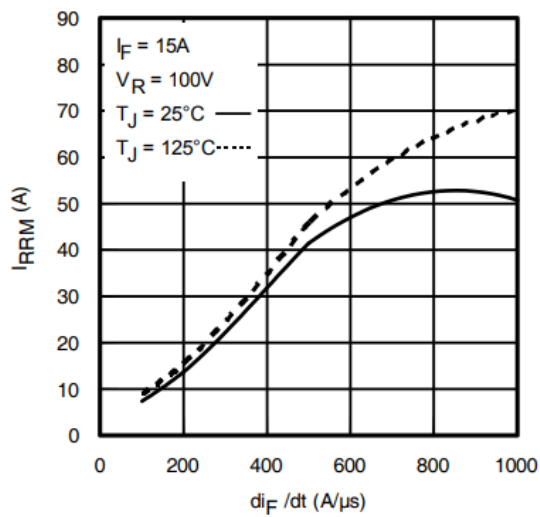
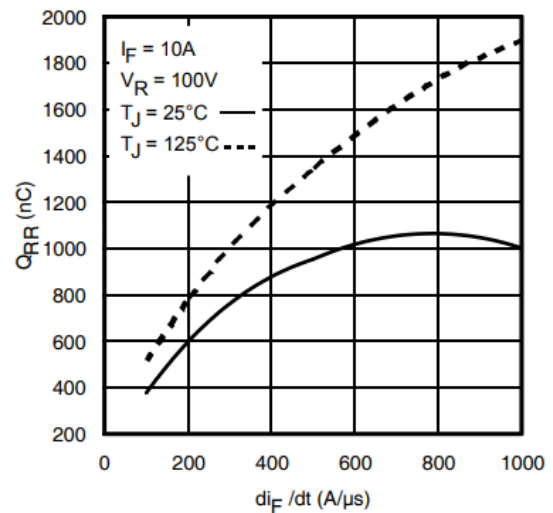
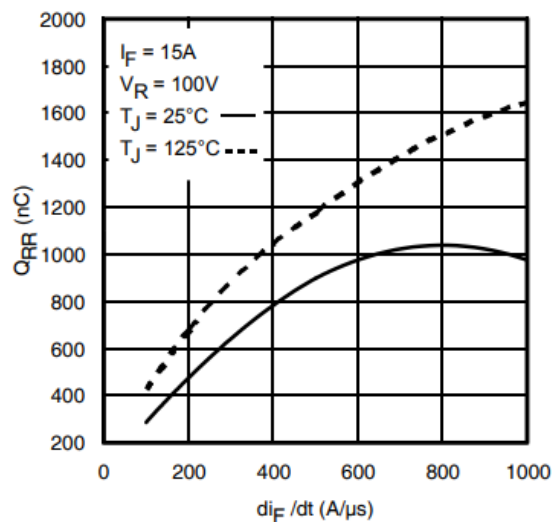


图 15.最大雪崩能量与温度的关系曲线

$$P_D(ave) = \frac{1}{2} (1.3 \cdot BV \cdot I_{av}) = \frac{\Delta T}{Z_{thJC}} I_{av}$$

$$= \frac{2 \Delta T}{[1.3 \cdot BV \cdot Z_{th}]}$$

$$EAS(AR) = P_D(ave) \cdot t_{av}$$


Fig 16. Threshold Voltage vs. Temperature

Fig. 17 - Typical Recovery Current vs. di_F/dt

Fig. 18 - Typical Recovery Current vs. di_F/dt

Fig. 19 - Typical Stored Charge vs. di_F/dt

Fig. 20 - Typical Stored Charge vs. di_F/dt

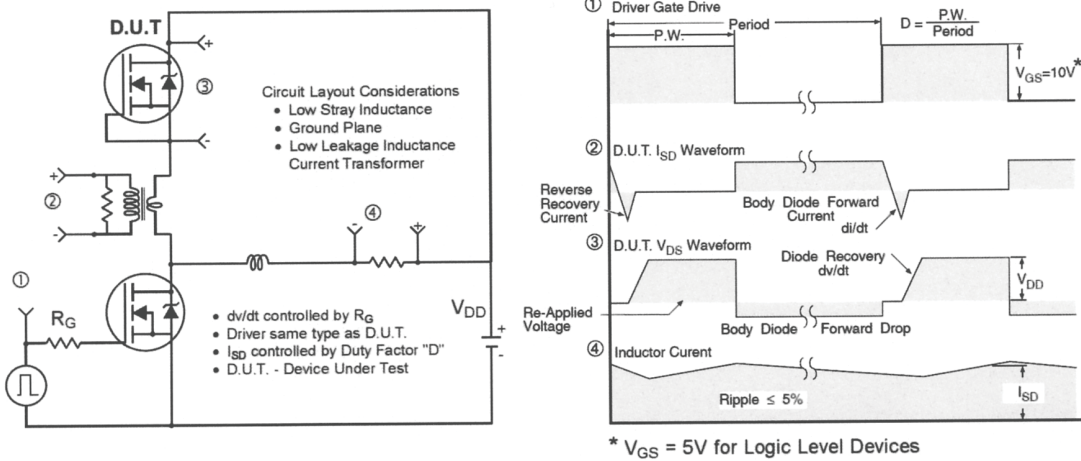


图 20. N 沟道 HEXFET® 功率 MOSFET 体内二极管峰值恢复 dv/dt 测试电路

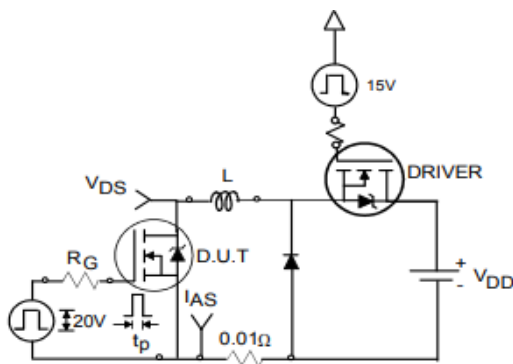


Fig 21a. Unclamped Inductive Test Circuit

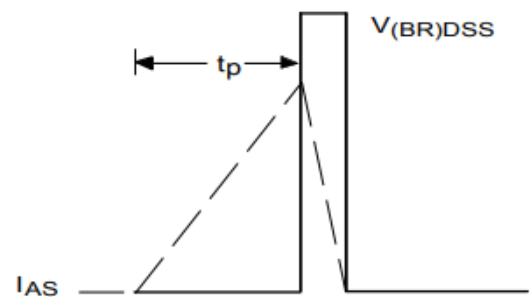


Fig 21b. Unclamped Inductive Waveforms

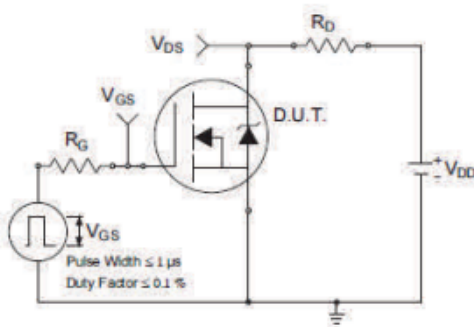


Fig 22a. Switching Time Test Circuit

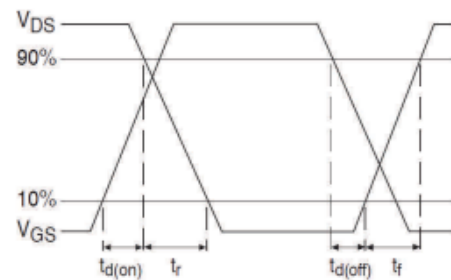


Fig 22b. Switching Time Waveforms

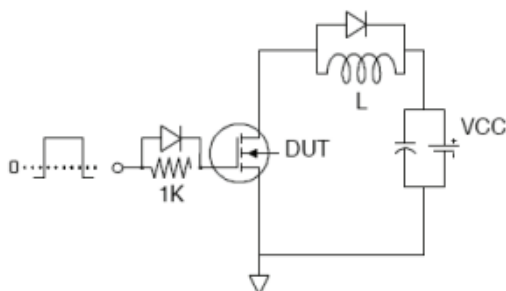


Fig 23a. Gate Charge Test Circuit

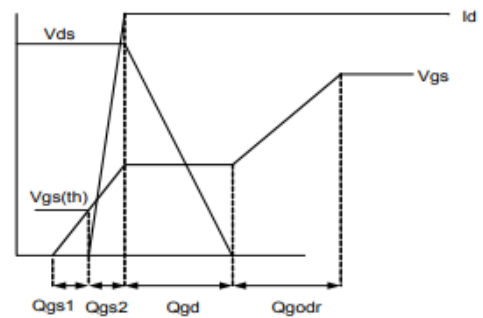
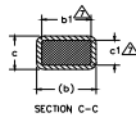
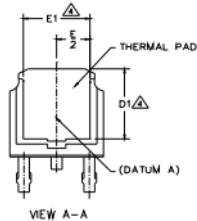
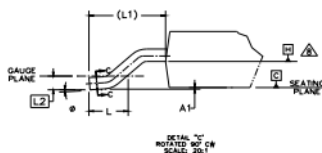
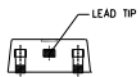
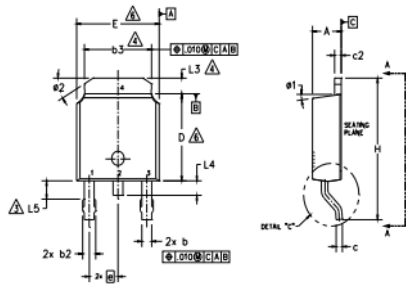


Fig 23b. Gate Charge Waveform

D-Pak (TO-252AA) 封装外形 (尺寸以毫米 (英寸) 为单位)

NOTES:

- 1.- DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
- 2.- DIMENSIONS ARE SHOWN IN INCHES [MILLIMETERS]
- 3.- LEAD DIMENSION UNCONTROLLED IN L5.
- 4.- DIMENSION D1, E1, L3 & b3 ESTABLISH A MINIMUM MOUNTING SURFACE FOR THERMAL PAD.
- 5.- SECTION C-C DIMENSIONS APPLY TO THE FLAT SECTION OF THE LEAD BETWEEN .005 AND 0.10 [0.13 AND 0.25] FROM THE LEAD TIP.
- 6.- DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED .005 [0.13] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY.
- 7.- DIMENSION b1 & c1 APPLIED TO BASE METAL ONLY.
- 8.- DATUM A & B TO BE DETERMINED AT DATUM PLANE H.
- 9.- OUTLINE CONFORMS TO JEDEC OUTLINE TO-252AA.

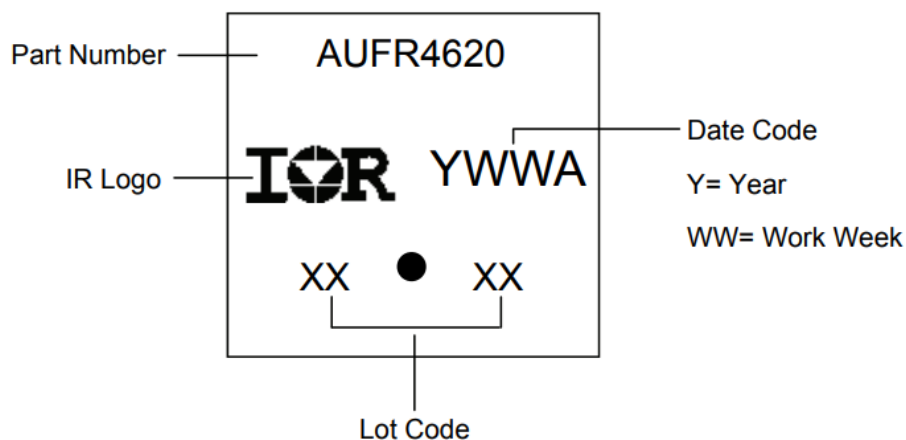
SYMBOL	DIMENSIONS				NOTES
	MILLIMETERS		INCHES		
	MIN.	MAX.	MIN.	MAX.	
A	2.18	2.39	.086	.094	
A1	—	0.13	—	.005	
b	0.64	0.89	.025	.035	
b1	0.65	0.79	.025	.031	7
b2	0.76	1.14	.030	.045	
b3	4.95	5.46	.195	.215	4
c	0.46	0.61	.018	.024	
c1	0.41	0.56	.016	.022	7
c2	0.46	0.89	.018	.035	
D	5.97	6.22	.235	.245	6
D1	5.21	—	.205	—	4
E	6.35	6.73	.250	.265	6
E1	4.32	—	.170	—	4
e	2.29 BSC		.090 BSC		
H	9.40	10.41	.370	.410	
L	1.40	1.78	.055	.070	
L1	2.74 BSC		.108 REF.		
L2	0.51 BSC		.020 BSC		
L3	0.89	1.27	.035	.050	4
L4	—	1.02	—	.040	
L5	1.14	1.52	.045	.060	3
ø	0"	10"	0"	10"	
ø1	0"	15"	0"	15"	
ø2	25"	35"	25"	35"	

LEAD ASSIGNMENTS
HEXFET

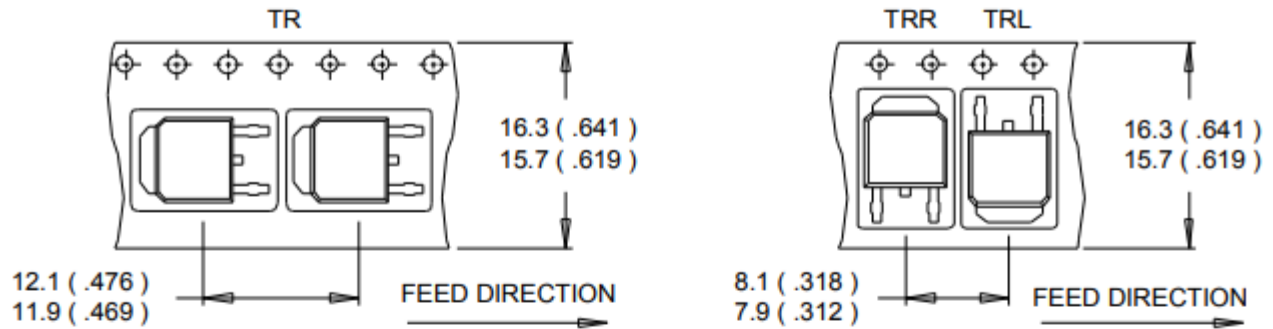
- 1.- GATE
- 2.- DRAIN
- 3.- SOURCE
- 4.- DRAIN

IGBT & CoPAK

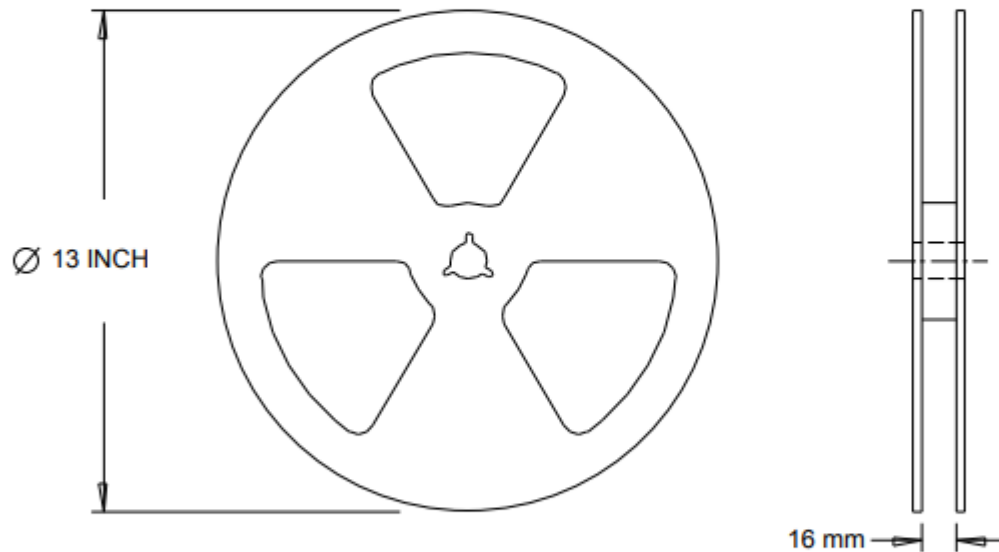
- 1.- GATE
- 2.- COLLECTOR
- 3.- EMITTER
- 4.- COLLECTOR

D-Pak (TO-252AA) 零件标识信息


Note: For the most current drawing please refer to IR website at <http://www.irf.com/package/>

D-Pak (TO-252AA) 卷带信息 (尺寸以毫米 (英寸) 为单位)

NOTES :

1. CONTROLLING DIMENSION : MILLIMETER.
2. ALL DIMENSIONS ARE SHOWN IN MILLIMETERS (INCHES).
3. OUTLINE CONFORMS TO EIA-481 & EIA-541.


NOTES :

1. OUTLINE CONFORMS TO EIA-481.

Note: For the most current drawing please refer to IR website at <http://www.irf.com/package/>

Qualification Information

Qualification Level		Automotive (per AEC-Q101)	
		Comments: This part number(s) passed Automotive qualification. Infineon's Industrial and Consumer qualification level is granted by extension of the higher Automotive level.	
Moisture Sensitivity Level		D-Pak	MSL1
ESD	Machine Model	Class M3 (+/- 400V) [†] AEC-Q101-002	
	Human Body Model	Class H1B (+/- 1000V) [†] AEC-Q101-001	
	Charged Device Model	Class C5 (+/- 2000V) [†] AEC-Q101-005	
RoHS Compliant		Yes	

† 最高通过电压。

修订记录

Date	Comments
12/1/2015	- Updated datasheet with corporate template - Corrected ordering table on page 1. - Updated typo on the fig.19 and fig.20, unit of y-axis from "A" to "nC" on page 6.

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